

PROCEEDINGS

IS&T / SPIE  
**Electronic  
Imaging**  
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# *Computational Imaging XII*

**Charles A. Bouman**  
**Ken D. Sauer**  
*Editors*

**5–6 February 2014**  
**San Francisco, California, United States**

*Sponsored and Published by*  
IS&T—The Society for Imaging Science and Technology  
SPIE

**Volume 9020**

Proceedings of SPIE 0277-786X, v. 9020

Computational Imaging XII, edited by Charles A. Bouman, Ken D. Sauer, Proc. of SPIE-IS&T Electronic Imaging,  
SPIE Vol. 9020, 902001 · © 2014 SPIE-IS&T · CCC code: 0277-786X/14/\$18 · doi: 10.1117/12.2063395

Proc. of SPIE-IS&T/ Vol. 9020 902001-1

The papers included in this volume were part of the technical conference cited on the cover and title page. Papers were selected and subject to review by the editors and conference program committee. Some conference presentations may not be available for publication. The papers published in these proceedings reflect the work and thoughts of the authors and are published herein as submitted. The publishers are not responsible for the validity of the information or for any outcomes resulting from reliance thereon.

Please use the following format to cite material from this book:

Author(s), "Title of Paper," in *Computational Imaging XII*, edited by Charles A. Bouman, Ken D. Sauer, Proceedings of SPIE-IS&T Electronic Imaging, SPIE Vol. 9020, Article CID Number (2014)

ISSN: 0277-786X

ISBN: 9780819499370

Copublished by

**SPIE**

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Printed in the United States of America.

**Paper Numbering:** Proceedings of SPIE follow an e-First publication model, with papers published first online and then in print and on CD-ROM. Papers are published as they are submitted and meet publication criteria. A unique, consistent, permanent citation identifier (CID) number is assigned to each article at the time of the first publication. Utilization of CIDs allows articles to be fully citable as soon as they are published online, and connects the same identifier to all online, print, and electronic versions of the publication. SPIE uses a six-digit CID article numbering system in which:

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